

Notice of References Cited	Application/Control No. 09/866,936	Applicant(s)/Patent Under Reexamination YANG ET AL.	
	Examiner Timothy M. Harbeck	Art Unit 3628	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Mary Lindahl, "Risk-Return Hedging Effectiveness Measures for Stock Index Futures; INTRODUCTION," The Journal of Futures Markets, New York: Aug 1991. Vol.11, Iss. 4; pg 399, 11 pgs.
	V	A.G. Malliaris and Jorge Urrutia, "Tests of Random Walk of Hedge Ratios and Measures of Hedging Effectiveness for Stock Indexes and Foreign Currencies," The Journal of Futures Markets, Hoboken: Feb 1991. Vol.11, Iss. 1; pg 55, 14 pgs.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.